Notice of References Cited Application/Control No. O9/844,673 Examiner J. Derek Rutten Applicant(s)/Patent Under Reexamination THEKKATH, RADHIKA Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,440,722 A	08-1995	VanderSpek et al.	714/43
	В	US-5,870,606 A	02-1999	Lindsey, Anthony Hayden	717/128
	С	US-			
	۵	US-		·	
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	I	US-			
	٦	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Þ					
	α					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U							
	V							
	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.